

2 WATT PIN MMIC HIGH ISOLATION SPDT SWITCH, 8 - 21 GHz

Typical Applications

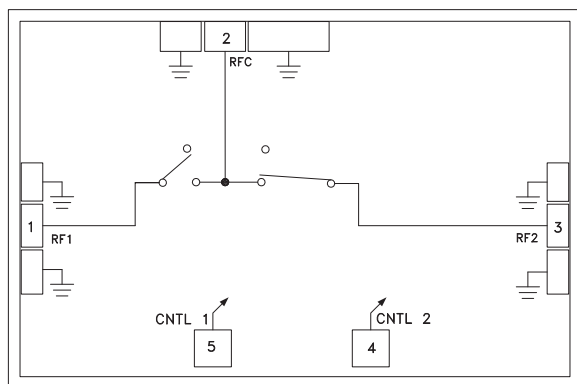
The HMC970 is ideal for:

- Telecom Infrastructure
- Microwave Radio & VSAT
- Military Radios, Radar & ECM
- Space Systems
- Test Instrumentation

Features

- High Isolation: 40 dB
- Low Insertion Loss: 1.2 dB
- All-Shunt Reflective Topology
- High Linearity: +50 dBm Input IP3
- Compact Die Size: 2.21 x 1.45 x 0.1 mm

Functional Diagram



General Description

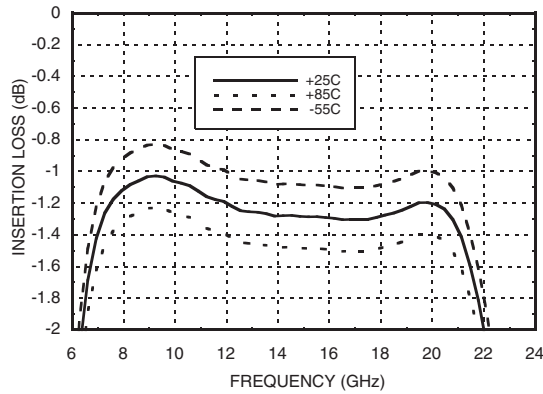
The HMC970 is a broadband high isolation all-shunt high IP3 design, reflective PIN SPDT MMIC chip. Covering 8 to 21 GHz, the switch features 40 dB isolation and low 1.2 dB isolation loss. The HMC970 is capable of switching 2W of power from 8 to 21 GHz. The HMC970 operates from a positive (30mA) supply current and a negative (-10V) supply voltage and includes on chip bias network, thus requiring no RF chokes to apply DC bias. Bias control signals for the switch consists of a reverse bias voltage of -10V typical for ON state and a forward bias current of 30 mA for the OFF state.

Electrical Specifications, $T_A = +25^\circ \text{C}$, With 30mA / -10V Control, 50 Ohm System

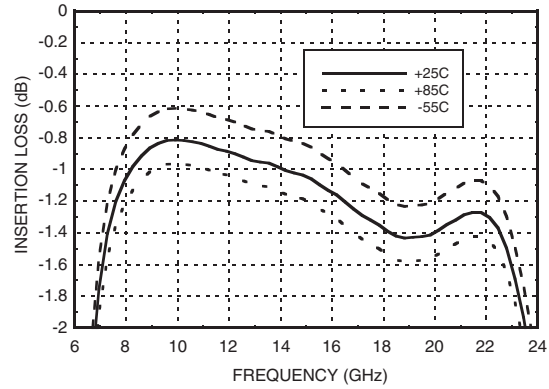
Parameter	Frequency	Min.	Typ.	Max.	Units
Insertion Loss RFC to RF1	8 - 12 GHz		1.1	1.4	dB
	12 - 21 GHz		1.3	1.7	dB
Insertion Loss RFC to RF2	8 - 14 GHz		0.9	1.2	dB
	14 - 18 GHz		1.2	1.6	dB
	18 - 21 GHz		1.4	1.7	dB
Isolation		35	40		dB
Return Loss	"On State"		10		dB dB
Input Power for 1 dB Compression			34		dBm
Input Third Order Intercept (Two-Tone Input Power= +16 dBm Each Tone, 1 MHz Tone Separation)			50		dBm

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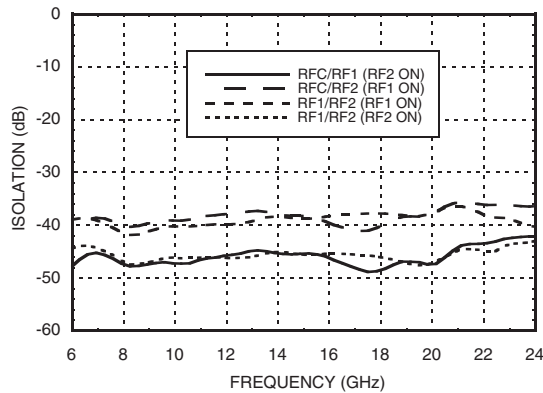
Insertion Loss, RFC to RF1



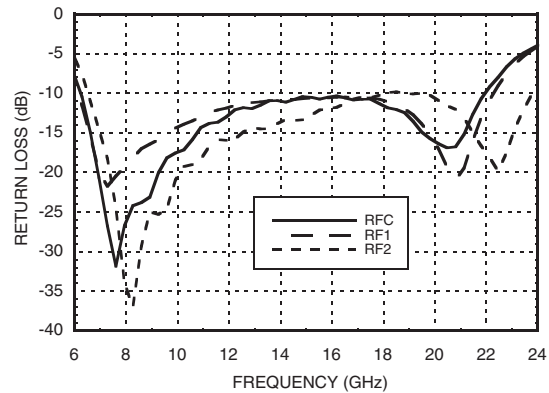
Isolation Loss, RFC to RF2



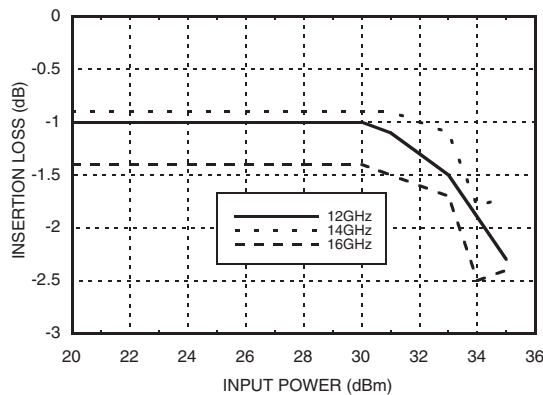
Isolation



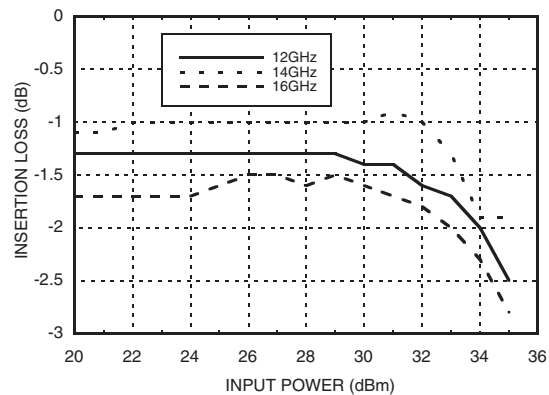
Return Loss



Insertion Loss vs. Pin, RFC to RF1



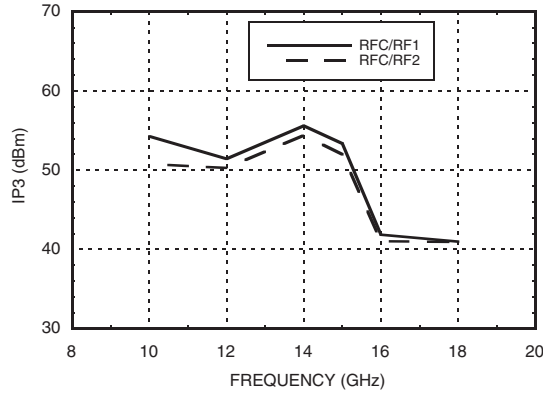
Insertion Loss vs. Pin, RFC to RF2



*Isolation data taken with probe on the die

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IP3 RFC to RF1 and RFC to RF2



Absolute Maximum Ratings

RF Input Power	+34 dBm
Negative Control Voltage	-14V
Forward Bias Current	100 mA
Storage Temperature	-65 to +150 °C
Operating Temperature	-55 to +85 °C



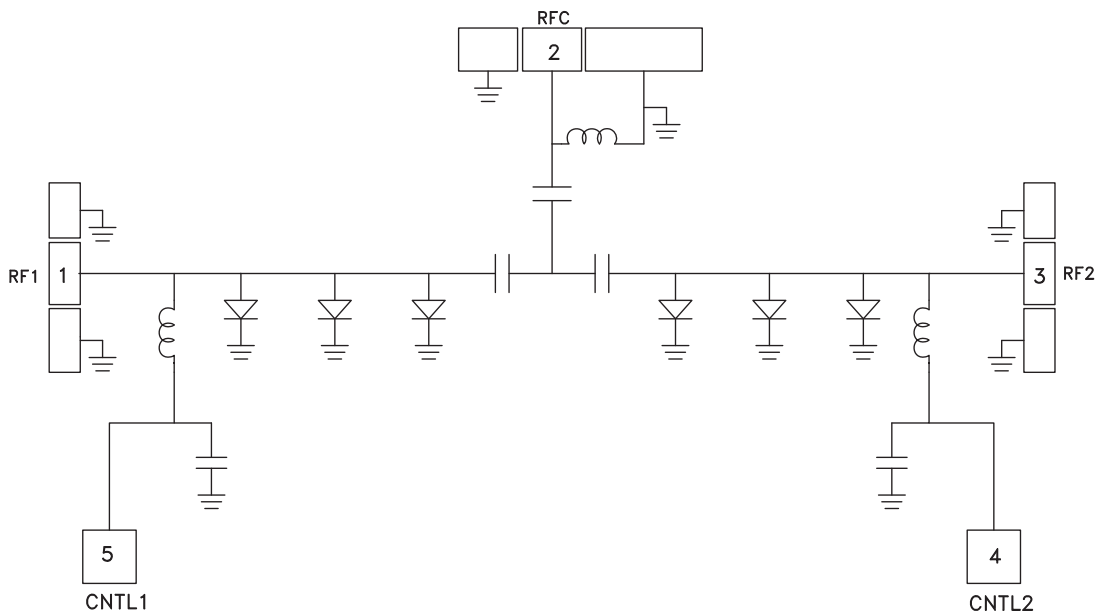
**ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS**

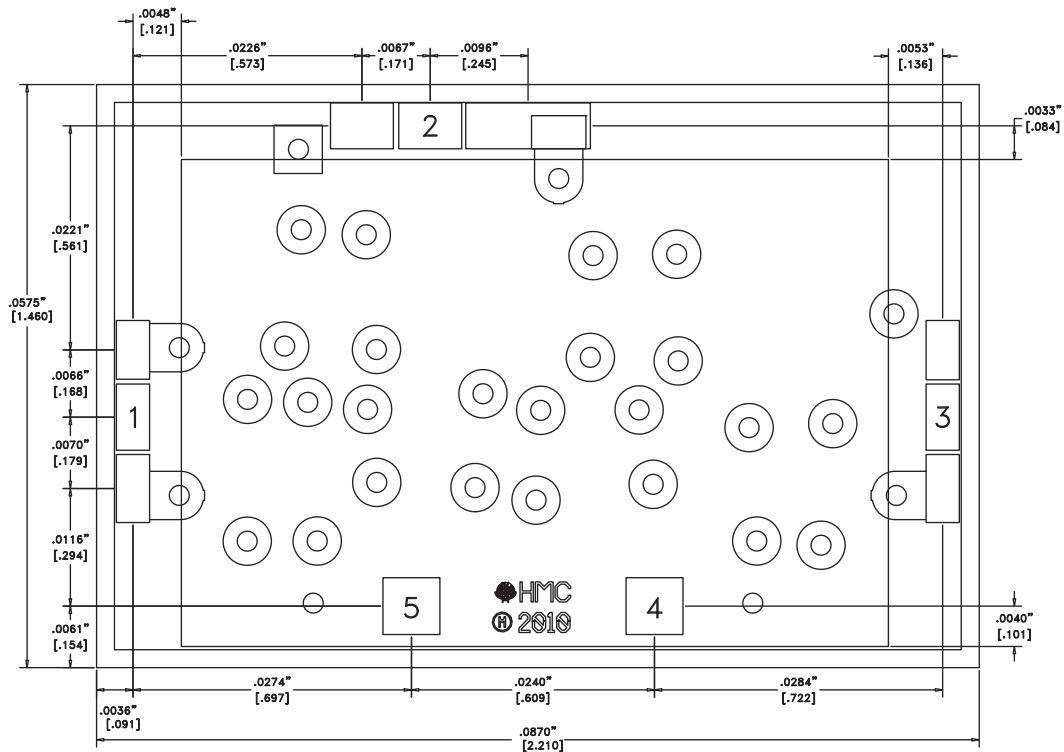
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Control Voltages

State	RFC - RF1	RFC - RF2	CNTL1	CNTL2
1	IL	Isol	-10V	+30mA / 1.29V
2	Isol	IL	+30mA / 1.29V	-10V

Equivalent Schematic



**2 WATT PIN MMIC HIGH ISOLATION
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Outline Drawing

Die Packaging Information ^[1]

Standard	Alternate
GP-1 (Gel Pack)	[2]

[1] Refer to the "Packaging Information" section for die packaging dimensions.

[2] For alternate packaging information contact Hittite Microwave Corporation.

NOTES:

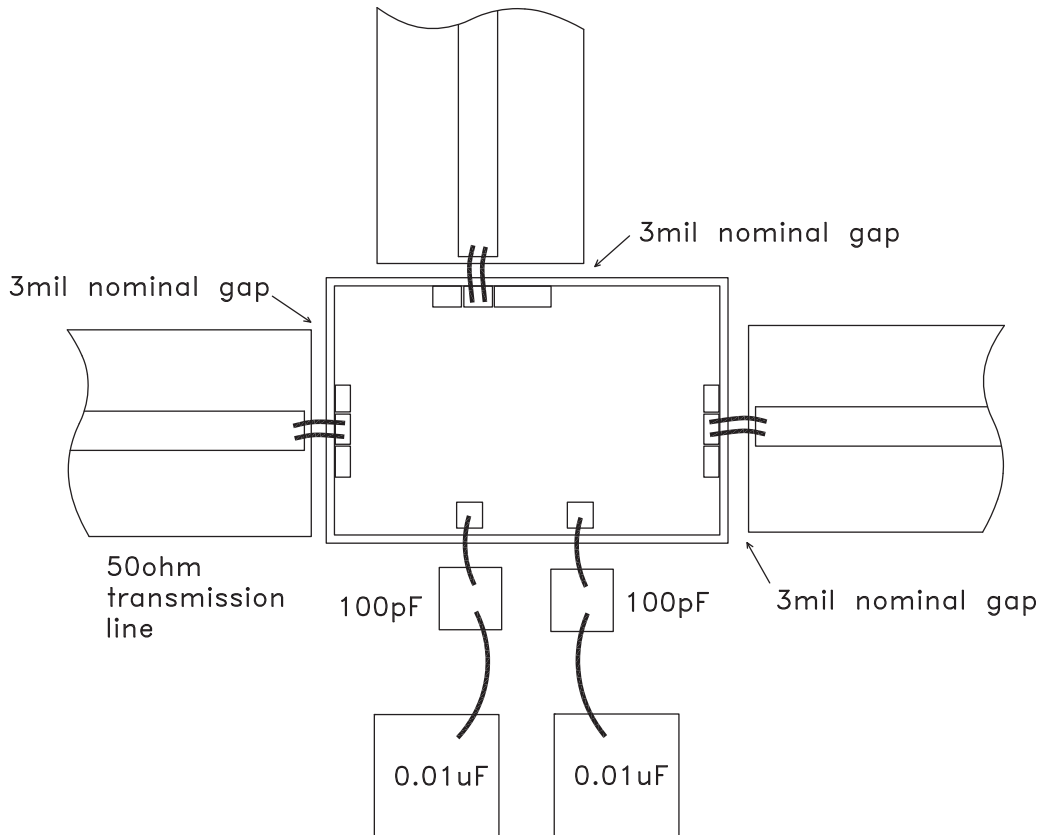
1. ALL DIMENSIONS ARE IN INCHES [MM]
2. DIE THICKNESS IS .004"
3. BACKSIDE METALIZATION: GOLD
4. BACKSIDE METAL IS GROUND
5. BOND PAD METALIZATION: GOLD
6. NO CONNECTION REQUIRED FOR UNLABELED BOND PADS.
7. OVERALL DIE SIZE $\pm .002$ "

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Pad Descriptions

Pad Number	Function	Description	Interface Schematic
1	RFC	RF common port. This port is DC shorted to ground through an on-chip inductor.	
2	RF1	RF Output port (path1) contains DC control voltage and also may be connected to the external DC bias through an RF choke.	
3	RF2	RF Output port (path2) contains DC control voltage and also may be connected to the external DC bias through an RF choke.	
4	CNTL1	DC control input for port 1.	
5	CTRL2	DC control input for port 2.	

Assembly Diagram



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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be brought as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm (3 mils).

Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025 mm (1 mil) diameter pure gold wire (DC bias, IF1 and IF2) or Ribbon Bond (RF and LO ports) 0.076 mm x 0.013 mm (3 mil x 0.5 mil) size is recommended. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31 mm (12 mils).

